

**Search Notes**

Application/Control No.

10/700,466

Examiner

Thien F. Tran

Applicant(s)/Patent under  
Reexamination

OHMI, TADAHIRO

Art Unit

2811

**SEARCHED**

Class	Subclass	Date	Examiner
257	347, 374	5/4/2005	TT
257	410, 411	5/4/2005	TT
257	501, 506	5/4/2005	TT
257	510, 325	5/4/2005	TT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR